The following changes were made to the MCB18xx board for USB Hi-Speed Test Certification.

1. The USB connectors P3, P4 and P5 were removed except connector P2 used for testing USB Hi-Speed device.
2. LM3526M-H switch to supply power for USB host was also removed.
3. The USB micro-AB connector was changed to micro-B connector (Device only test certification).
4. The value of C36 was changed from 4.7uF to 2.2uF (2.2uF is the recommended value to place on VBUS; 1uF is minimum, but 2.2uF provides margin for actual capacitance on the low end of tolerance).

The following figure shows the above changes.

